

Automotive-Grade, Galvanically Isolated Current Sensor IC with Common-Mode Field Rejection in a Small-Footprint SOIC8 Package

FEATURES AND BENEFITS

- · AEC-Q100 qualified
- Differential Hall sensing rejects common-mode fields
- 1.2 m Ω primary conductor resistance for low power loss and high inrush current withstand capability
- Integrated shield virtually eliminates capacitive coupling from current conductor to die, greatly suppressing output noise due to high dv/dt transients
- Industry-leading noise performance with greatly improved bandwidth through proprietary amplifier and filter design techniques
- High-bandwidth 120 kHz analog output for faster response times in control applications
- Filter pin allows user to filter the output for improved resolution at lower bandwidth
- Patented integrated digital temperature compensation circuitry allows for near closed loop accuracy over temperature in an open loop sensor
- Small-footprint, low-profile SOIC8 package suitable for space-constrained applications
- Filter pin simplifies bandwidth limiting for better resolution at lower frequencies

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CB Certificate Number: US-32848-UL

PACKAGE: 8-Pin SOIC (suffix LC)



Not to scale

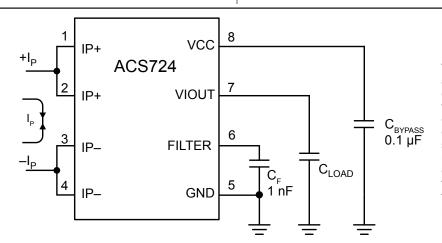
DESCRIPTION

The Allegro™ ACS724 current sensor IC is an economical and precise solution for AC or DC current sensing in industrial, automotive, commercial, and communications systems. The small package is ideal for space-constrained applications while also saving costs due to reduced board area. Typical applications include motor control, load detection and management, switched-mode power supplies, and overcurrent fault protection.

The device consists of a precise, low-offset, linear Hall sensor circuit with a copper conduction path located near the surface of the die. Applied current flowing through this copper conduction path generates a magnetic field which is sensed by the integrated Hall IC and converted into a proportional voltage. The current is sensed differentially in order to reject common-mode fields, improving accuracy in magnetically noisy environments. The inherent device accuracy is optimized through the close proximity of the magnetic field to the Hall transducer. A precise, proportional voltage is provided by the low-offset, chopper-stabilized BiCMOS Hall IC, which is programmed for accuracy after packaging. The output of the device has a positive slope when an increasing current flows through the primary copper conduction path (from pins 1 and 2, to pins 3 and 4), which is the path used for current sensing. The internal resistance of this conductive path is $1.2 \,\mathrm{m}\Omega$ typical, providing low power loss.

The terminals of the conductive path are electrically isolated from the sensor leads (pins 5 through 8). This allows the ACS724 current sensor IC to be used in high-side current sense applications without the use of high-side differential amplifiers or other costly isolation techniques.

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The ACS724 outputs an analog signal, V_{IOUT}, that changes proportionally with the bidirectional AC or DC primary sensed current, I_P, within the specified measurement range. The FILTER pin can be used to decrease the bandwidth in order to optimize the noise performance.

Typical Application

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FEATURES AND BENEFITS (continued)

- 5 V, single supply operation
- Output voltage proportional to AC or DC current
- Factory-trimmed sensitivity and quiescent output voltage for improved accuracy
- Chopper stabilization results in extremely stable quiescent output voltage
- Nearly zero magnetic hysteresis
- Ratiometric output from supply voltage

DESCRIPTION (continued)

The ACS724 is provided in a small, low-profile surface-mount SOIC8 package. The leadframe is plated with 100% matte tin, which is compatible with standard lead (Pb) free printed circuit board assembly processes. Internally, the device is Pb-free, except for flip-chip high-temperature Pb-based solder balls, currently exempt from RoHS. The device is fully calibrated prior to shipment from the factory.

SELECTION GUIDE

| Part Number | I _{PR} (A) | Sens(Typ) at V _{CC} = 5 V (mV/A) | T _A (°C) | Packing* |
|---------------------|---------------------|-------------------------------------------------|------------------------|-------------------------------------|
| ACS724LLCTR-2P5AB-T | ±2.5 | 800 | | |
| ACS724LLCTR-05AB-T | ±5 | 400 | | |
| ACS724LLCTR-10AU-T | 10 | 400 | | |
| ACS724LLCTR-10AB-T | ±10 | 200 | | |
| ACS724LLCTR-20AU-T | 20 | 200 | 40.1 450 | Tana and Baal 2000 nicese per real |
| ACS724LLCTR-20AB-T | ±20 | 100 | -40 to 150 | Tape and Reel, 3000 pieces per reel |
| ACS724LLCTR-30AU-T | 30 | 133 | | |
| ACS724LLCTR-30AB-T | ±30 | 66 | | |
| ACS724LLCTR-40AU-T | 40 | 100 | | |
| ACS724LLCTR-50AB-T | ±50 | 40 |] | |

^{*}Contact Allegro for additional packing options.



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SPECIFICATIONS

ABSOLUTE MAXIMUM RATINGS

| Characteristic | Symbol | Notes | Rating | Units |
|-------------------------------|----------------------|---------|-----------------------|-------|
| Supply Voltage | V _{CC} | | 6 | V |
| Reverse Supply Voltage | V _{RCC} | | -0.1 | V |
| Output Voltage | V _{IOUT} | | V _{CC} + 0.5 | V |
| Reverse Output Voltage | V _{RIOUT} | | -0.1 | V |
| Operating Ambient Temperature | T _A | Range L | -40 to 150 | °C |
| Junction Temperature | T _J (max) | | 165 | °C |
| Storage Temperature | T _{stg} | | -65 to 165 | °C |

ISOLATION CHARACTERISTICS

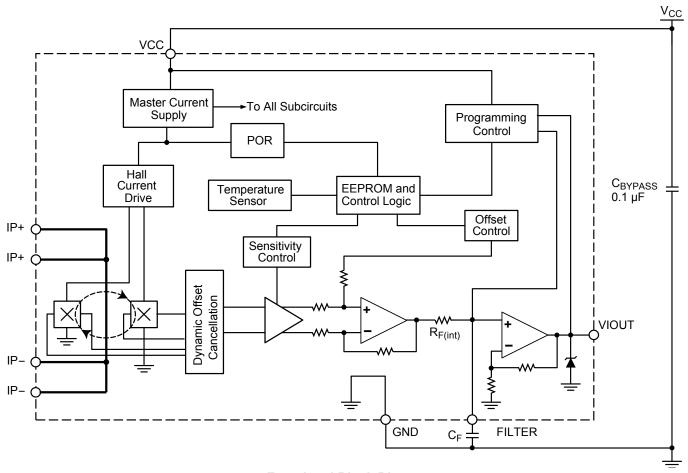
| Characteristic | Characteristic Symbol Notes | | Rating | Unit |
|----------------------------------------|-----------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------|------------------------|
| Dielectric Surge Strength Test Voltage | V _{SURGE} | Tested ±5 pulses at 2/minute in compliance to IEC 61000-4-5 1.2 µs (rise) / 50 µs (width). | 6000 | V |
| Dielectric Strength Test Voltage | V_{ISO} | Agency type-tested for 60 seconds per UL standard 60950-1 (edition 2); production-tested at $V_{\rm ISO}$ for 1 second, in accordance with UL 60950-1 (edition 2). | 2400 | V _{RMS} |
| Working Voltage for Basic Isolation | V | Maximum approved working voltage for basic (single) | 420 | V _{pk} or VDC |
| Working Voltage for Basic Isolation | V_{WVBI} | isolation according to UL 60950-1 (edition 2) | 297 | V _{rms} |
| Clearance | D _{cl} | Minimum distance through air from IP leads to signal leads. | 4.2 | mm |
| Creepage | D _{cr} | Minimum distance along package body from IP leads to signal leads. | 4.2 | mm |

THERMAL CHARACTERISTICS

| Characteristic | Symbol | Test Conditions* | Value | Units |
|-----------------------------------------------------|------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------|-------|
| Package Thermal Resistance (Junction to Ambient) | R _{θJA} | Mounted on the Allegro 85-0740 evaluation board with 800 mm² of 4 oz. copper on each side, connected to pins 1 and 2, and to pins 3 and 4, with thermal vias connecting the layers. Performance values include the power consumed by the PCB. | 23 | °C/W |
| Package Thermal Resistance (Junction to Lead) | R _{θJL} | Mounted on the Allegro ASEK724 evaluation board. | 5 | °C/W |

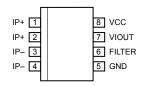
^{*}Additional thermal information available on the Allegro website.





Functional Block Diagram

PINOUT DIAGRAM AND TERMINAL LIST TABLE



Package LC, 8-Pin SOICN Pinout Diagram

Terminal List Table

| Number | Name | Description |
|--------|--------|------------------------------------------------------|
| 1, 2 | IP+ | Terminals for current being sensed; fused internally |
| 3, 4 | IP- | Terminals for current being sensed; fused internally |
| 5 | GND | Signal ground terminal |
| 6 | FILTER | Terminal for external capacitor that sets bandwidth |
| 7 | VIOUT | Analog output signal |
| 8 | VCC | Device power supply terminal |



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COMMON ELECTRICAL CHARACTERISTICS [1]: Valid through the full range of T_A , V_{CC} = 5 V, C_F = 0, unless otherwise specified

| Characteristic | Symbol | Test Conditions | Min. | Тур. | Max. | Unit |
|--------------------------------------------|-----------------------|----------------------------------------------------------------------------------------------------------------------------|------|-----------------------|------|------------------------------|
| Supply Voltage | V _{CC} | | 4.5 | _ | 5.5 | V |
| Supply Current | I _{CC} | V _{CC} = 5 V, output open | _ | 10 | 14 | mA |
| Output Capacitance Load | C _L | VIOUT to GND | _ | _ | 10 | nF |
| Output Resistive Load | R_L | VIOUT to GND | 4.7 | _ | _ | kΩ |
| Primary Conductor Resistance | R _{IP} | T _A = 25°C | _ | 1.2 | _ | mΩ |
| Internal Filter Resistance [2] | R _{F(int)} | | _ | 1.8 | _ | kΩ |
| Common Mode Field Rejection Ratio | CMFRR | Uniform external magnetic field | _ | 40 | _ | dB |
| Primary Hall Coupling Factor | G1 | T _A = 25°C | _ | 11 | _ | G/A |
| Secondary Hall Coupling Factor | G2 | T _A = 25°C | _ | 2.8 | _ | G/A |
| Hall Plate Sensitivity Matching | Sens _{match} | T _A = 25°C | _ | ±1 | _ | % |
| Rise Time | t _r | $I_P = I_P(max), T_A = 25^{\circ}C, C_L = 1 \text{ nF}$ | _ | 3 | _ | μs |
| Propagation Delay | t _{pd} | $I_P = I_P(max), T_A = 25^{\circ}C, C_L = 1 \text{ nF}$ | _ | 2 | _ | μs |
| Response Time | t _{RESPONSE} | $I_P = I_P(max), T_A = 25^{\circ}C, C_L = 1 \text{ nF}$ | _ | 4 | _ | μs |
| Bandwidth | BW | Small signal –3 dB; C _L = 1 nF | _ | 120 | _ | kHz |
| Noise Density | I _{ND} | Input-referenced noise density; T _A = 25°C, C _L = 1 nF | - | 150 | _ | µA _(rms) / √Hz |
| Noise | I _N | Input-referenced noise: $C_F = 4.7 \text{ nF}$, $C_L = 1 \text{ nF}$, $BW = 18 \text{ kHz}$, $T_A = 25^{\circ}\text{C}$ | - | 20 | _ | mA _(rms) |
| Nonlinearity | E _{LIN} | Through full range of I _P | -1.5 | _ | +1.5 | % |
| Sensitivity Ratiometry Coefficient | SENS_RAT_ COEF | V _{CC} = 4.5 to 5.5 V, T _A = 25°C | - | 1.3 | _ | - |
| Zero-Current Output Ratiometry Coefficient | QVO_RAT_ COEF | V _{CC} = 4.5 to 5.5 V, T _A = 25°C | _ | 1 | _ | _ |
| O-t | V _{OH} | $R_L = 4.7 \text{ k}\Omega$ | _ | V _{CC} - 0.3 | _ | V |
| Saturation Voltage [3] | V _{OL} | $R_L = 4.7 \text{ k}\Omega$ | _ | 0.3 | _ | V |
| Power-On Time | t _{PO} | Output reaches 90% of steady-state level, T _A = 25°C, I _P = I _{PR} (max) applied | - | 80 | _ | μs |
| Shorted Output-to-Ground Current | I _{SC(GND)} | T _A = 25°C | _ | 3.3 | _ | mA |
| Shorted Output-to-V _{CC} Current | I _{SC(VCC)} | T _A = 25°C | _ | 45 | _ | mA |

^[1] Device may be operated at higher primary current levels, I_P, ambient temperatures, T_A, and internal leadframe temperatures, provided the Maximum Junction Temperature, T_J(max), is not exceeded.

[2] R_{F(int)} forms an RC circuit via the FILTER pin.



^[3] The sensor IC will continue to respond to current beyond the range of I_p until the high or low saturation voltage; however, the nonlinearity in this region will be worse than through the rest of the measurement range.

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xLLCTR-2P5AB PERFORMANCE CHARACTERISTICS: T_A Range L, valid at $T_A = -40$ °C to 150°C, $V_{CC} = 5$ V, unless otherwise specified

| Characteristic | Symbol | Test Conditions | Min. | Typ.[1] | Max. | Unit |
|-----------------------------------|-------------------------|----------------------------------------------------------------------------------------------|------|-----------------------|------|------|
| NOMINAL PERFORMANCE | | | | | | |
| Current Sensing Range | I _{PR} | | -2.5 | _ | 2.5 | А |
| Sensitivity | Sens | $I_{PR(min)} < I_{P} < I_{PR(max)}$ | _ | 800 | - | mV/A |
| Zero-Current Output Voltage | V _{IOUT(Q)} | Bidirectional, I _P = 0 A | _ | V _{CC} × 0.5 | _ | V |
| ACCURACY PERFORMANC | E | | | | | |
| Total Output Error [2] | E _{TOT} | I _P = I _{PR(max)} , T _A = 25°C to 150°C | -2.5 | ±1.5 | 2.5 | % |
| Total Output Error (=) | | $I_{P} = I_{PR(max)}, T_{A} = -40^{\circ}C \text{ to } 25^{\circ}C$ | -6.5 | ±4.5 | 6.5 | % |
| TOTAL OUTPUT ERROR CO | MPONENTS | S [3] E _{TOT} = E _{SENS} + 100 × V _{OE} /(Sens × I _P) | | | | |
| Sensitivity Error | _ | $I_P = I_{PR(max)}, T_A = 25^{\circ}C \text{ to } 150^{\circ}C$ | -2 | ±1 | 2 | % |
| Sensitivity End | E _{sens} | $I_P = I_{PR(max)}$, $T_A = -40$ °C to 25°C | -6 | ±4.5 | 6 | % |
| Offeet Voltage | \/ | I _P = 0 A, T _A = 25°C to 150°C | -20 | ±7 | 20 | mV |
| Offset Voltage | V _{OE} | $I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$ | -40 | ±13 | 40 | mV |
| LIFETIME DRIFT CHARACT | ERISTICS | | | | | |
| Sensitivity Error Lifetime Drift | E _{sens_drift} | | -3 | ±1 | 3 | % |
| Total Output Error Lifetime Drift | E _{tot_drift} | | -3 | ±1 | 3 | % |

^[1] Typical values with +/- are 3 sigma values.



^[2] Percentage of I_P, with I_P = I_{PR(max)}.

[3] A single part will not have both the maximum/minimum sensitivity error and maximum/minimum offset voltage, as that would violate the maximum/minimum total output error specification. Also, 3 sigma distribution values are combined by taking the square root of the sum of the squares. See Application Information section.

Automotive-Grade, Galvanically Isolated Current Sensor IC with Common-Mode Field Rejection in a Small-Footprint SOIC8 Package

xLLCTR-05AB PERFORMANCE CHARACTERISTICS: T_A Range L, valid at T_A = -40°C to 150°C, V_{CC} = 5 V, unless otherwise specified

| Characteristic | Symbol | Test Conditions | Min. | Typ.[1] | Max. | Unit |
|-----------------------------------|-------------------------|----------------------------------------------------------------------------------------------|------|-----------------------|------|------|
| NOMINAL PERFORMANCE | | | ` | | | |
| Current Sensing Range | I _{PR} | | -5 | _ | 5 | А |
| Sensitivity | Sens | $I_{PR(min)} < I_{P} < I_{PR(max)}$ | _ | 400 | _ | mV/A |
| Zero-Current Output Voltage | V _{IOUT(Q)} | Bidirectional, I _P = 0 A | _ | V _{CC} × 0.5 | - | V |
| ACCURACY PERFORMANC | E | | | | | |
| Total Output Francis | E _{TOT} | $I_{P} = I_{PR(max)}, T_{A} = 25^{\circ}C \text{ to } 150^{\circ}C$ | -2.5 | ±1.5 | 2.5 | % |
| Total Output Error [2] | | $I_P = I_{PR(max)}$, $T_A = -40$ °C to 25°C | -6 | ±4.5 | 6 | % |
| TOTAL OUTPUT ERROR CO | MPONENTS | S [3] E _{TOT} = E _{SENS} + 100 × V _{OE} /(Sens × I _P) | | | | |
| Concitivity Fran | _ | $I_{P} = I_{PR(max)}, T_{A} = 25^{\circ}C \text{ to } 150^{\circ}C$ | -2 | ±1 | 2 | % |
| Sensitivity Error | E _{sens} | $I_P = I_{PR(max)}$, $T_A = -40$ °C to 25°C | -5.5 | ±4.5 | 5.5 | % |
| Offact Voltage | V | I _P = 0 A, T _A = 25°C to 150°C | -15 | ±7 | 15 | mV |
| Offset Voltage | V _{OE} | $I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$ | -30 | ±13 | 30 | mV |
| LIFETIME DRIFT CHARACT | ERISTICS | - | | | | |
| Sensitivity Error Lifetime Drift | E _{sens_drift} | | -3 | ±1 | 3 | % |
| Total Output Error Lifetime Drift | E _{tot_drift} | | -3 | ±1 | 3 | % |

^[1] Typical values with +/- are 3 sigma values.



^[3] A single part will not have both the maximum/minimum sensitivity error and maximum/minimum offset voltage, as that would violate the maximum/minimum total output error specification. Also, 3 sigma distribution values are combined by taking the square root of the sum of the squares. See Application Information section.

Automotive-Grade, Galvanically Isolated Current Sensor IC with Common-Mode Field Rejection in a Small-Footprint SOIC8 Package

xLLCTR-10AU PERFORMANCE CHARACTERISTICS: T_A Range L, valid at T_A = -40°C to 150°C, V_{CC} = 5 V, unless otherwise specified

| Characteristic | Symbol | Test Conditions | Min. | Typ.[1] | Max. | Unit | | | |
|-----------------------------------|-------------------------|----------------------------------------------------------------------------------------------|------|-----------------------|------|------|--|--|--|
| NOMINAL PERFORMANCE | | | | | | | | | |
| Current-Sensing Range | I _{PR} | | 0 | _ | 10 | Α | | | |
| Sensitivity | Sens | $I_{PR(min)} < I_{P} < I_{PR(max)}$ | _ | 400 | _ | mV/A | | | |
| Zero-Current Output Voltage | V _{IOUT(Q)} | Unidirectional, I _P = 0 A | _ | V _{CC} × 0.1 | _ | V | | | |
| ACCURACY PERFORMANC | E | | | | | | | | |
| Total Output Error [2] | E _{TOT} | $I_P = I_{PR(max)}, T_A = 25^{\circ}C \text{ to } 150^{\circ}C$ | -2.5 | ±1.5 | 2.5 | % | | | |
| Total Output Error (=) | | $I_P = I_{PR(max)}, T_A = -40^{\circ}C \text{ to } 25^{\circ}C$ | -6 | ±4.5 | 6 | % | | | |
| TOTAL OUTPUT ERROR CO | MPONENTS | S [3] E _{TOT} = E _{SENS} + 100 × V _{OE} /(Sens × I _P) | | | | | | | |
| Sensitivity Error | E _{sens} | $I_P = I_{PR(max)}, T_A = 25^{\circ}C \text{ to } 150^{\circ}C$ | -2 | ±1 | 2 | % | | | |
| Sensitivity Error | ⊏sens | $I_P = I_{PR(max)}, T_A = -40^{\circ}C \text{ to } 25^{\circ}C$ | -5.5 | ±4.5 | 5.5 | % | | | |
| Offset Voltage | .,, | $I_P = 0 \text{ A}, T_A = 25^{\circ}\text{C to } 150^{\circ}\text{C}$ | -15 | ±7 | 15 | mV | | | |
| Offset Voltage | V _{OE} | $I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$ | -30 | ±13 | 30 | mV | | | |
| LIFETIME DRIFT CHARACT | ERISTICS | | | | | | | | |
| Sensitivity Error Lifetime Drift | E _{sens_drift} | | -3 | ±1 | 3 | % | | | |
| Total Output Error Lifetime Drift | E _{tot_drift} | | -3 | ±1 | 3 | % | | | |

^[1] Typical values with +/- are 3 sigma values.



^[2] Percentage of |p, with |p= |p_{R(max)}.

[3] A single part will not have both the maximum/minimum sensitivity error and maximum/minimum offset voltage, as that would violate the maximum/minimum total output error specification. Also, 3 sigma distribution values are combined by taking the square root of the sum of the squares. See Application Information section.

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xLLCTR-10AB PERFORMANCE CHARACTERISTICS: T_A Range L, valid at T_A = -40°C to 150°C, V_{CC} = 5 V, unless otherwise specified

| Characteristic | Symbol | Test Conditions | Min. | Typ.1 | Max. | Unit |
|-----------------------------------|-------------------------|-----------------------------------------------------------------------|------|-----------------------|------|------|
| NOMINAL PERFORMANCE | | | | | | |
| Current-Sensing Range | I _{PR} | | -10 | _ | 10 | Α |
| Sensitivity | Sens | $I_{PR(min)} < I_{P} < I_{PR(max)}$ | _ | 200 | _ | mV/A |
| Zero-Current Output Voltage | V _{IOUT(Q)} | Bidirectional, I _P = 0 A | _ | V _{CC} × 0.5 | - | V |
| ACCURACY PERFORMANC | E | | | | | |
| Total Output Error ² | E _{TOT} | $I_P = I_{PR(max)}, T_A = 25^{\circ}C \text{ to } 150^{\circ}C$ | -2 | ±1 | 2 | % |
| Total Output Error2 | | $I_P = I_{PR(max)}, T_A = -40^{\circ}C \text{ to } 25^{\circ}C$ | -6 | ±4.5 | 6 | % |
| TOTAL OUTPUT ERROR CO | MPONENTS | $S^3 E_{TOT} = E_{SENS} + 100 \times V_{OE}/(Sens \times I_P)$ | | | | |
| Sonoitivity Error | _ | $I_P = I_{PR(max)}, T_A = 25^{\circ}C \text{ to } 150^{\circ}C$ | -1.5 | ±1 | 1.5 | % |
| Sensitivity Error | E _{sens} | $I_P = I_{PR(max)}$, $T_A = -40$ °C to 25°C | -5.5 | ±4.5 | 5.5 | % |
| Offset Voltage | V | I _P = 0 A, T _A = 25°C to 150°C | -10 | ±6 | 10 | mV |
| Offset voltage | V _{OE} | $I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$ | -30 | ±8 | 30 | mV |
| LIFETIME DRIFT CHARACT | ERISTICS | | | | | |
| Sensitivity Error Lifetime Drift | E _{sens_drift} | | -3 | ±1 | 3 | % |
| Total Output Error Lifetime Drift | E _{tot_drift} | | -3 | ±1 | 3 | % |

^[1] Typical values with +/- are 3 sigma values.



^[2] Percentage of I_P, with I_P = I_{PR(max)}.

[3] A single part will not have both the maximum/minimum sensitivity error and maximum/minimum offset voltage, as that would violate the maximum/minimum total output error specification. Also, 3 sigma distribution values are combined by taking the square root of the sum of the squares. See Application Information section.

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xLLCTR-20AU PERFORMANCE CHARACTERISTICS: T_A Range L, valid at T_A = -40°C to 150°C, V_{CC} = 5 V, unless otherwise specified

| Characteristic | Symbol | Test Conditions | Min. | Typ. [1] | Max. | Unit |
|-----------------------------------|-------------------------|----------------------------------------------------------------------------------------------|------|-----------------------|------|------|
| NOMINAL PERFORMANCE | | | | | | |
| Current-Sensing Range | I _{PR} | | 0 | - | 20 | Α |
| Sensitivity | Sens | $I_{PR(min)} < I_{P} < I_{PR(max)}$ | _ | 200 | _ | mV/A |
| Zero-Current Output Voltage | V _{IOUT(Q)} | Unidirectional, I _P = 0 A | _ | V _{CC} × 0.1 | _ | V |
| ACCURACY PERFORMANC | E | | | | | |
| Total Output Error [2] | E _{TOT} | $I_P = I_{PR(max)}, T_A = 25^{\circ}C \text{ to } 150^{\circ}C$ | -2 | ±0.7 | 2 | % |
| Total Output Error (=) | | $I_{P} = I_{PR(max)}, T_{A} = -40^{\circ}C \text{ to } 25^{\circ}C$ | -6 | ±4 | 6 | % |
| TOTAL OUTPUT ERROR CO | MPONENTS | S [3] E _{TOT} = E _{SENS} + 100 × V _{OE} /(Sens × I _P) | | | | |
| Sonoitivity Error | _ | $I_P = I_{PR(max)}, T_A = 25^{\circ}C \text{ to } 150^{\circ}C$ | -1.5 | ±0.7 | 1.5 | % |
| Sensitivity Error | E _{sens} | $I_P = I_{PR(max)}$, $T_A = -40$ °C to 25°C | -5.5 | ±4 | 5.5 | % |
| Offset Voltage | V | I _P = 0 A, T _A = 25°C to 150°C | -10 | ±6 | 10 | mV |
| Oliset voltage | V _{OE} | $I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$ | -30 | ±8 | 30 | mV |
| LIFETIME DRIFT CHARACT | ERISTICS | | | | | |
| Sensitivity Error Lifetime Drift | E _{sens_drift} | | -3 | ±1 | 3 | % |
| Total Output Error Lifetime Drift | E _{tot_drift} | | -3 | ±1 | 3 | % |

^[1] Typical values with +/- are 3 sigma values.



^[2] Percentage of I_P, with I_P = I_{PR(max)}.

[3] A single part will not have both the maximum/minimum sensitivity error and maximum/minimum offset voltage, as that would violate the maximum/minimum total output error specification. Also, 3 sigma distribution values are combined by taking the square root of the sum of the squares. See Application Information section.

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| Characteristic | Symbol | Test Conditions | Min. | Typ. [1] | Max. | Unit |
|-----------------------------------|-------------------------|----------------------------------------------------------------------------------------------|------|-----------------------|------|------|
| NOMINAL PERFORMANCE | | | | | | |
| Current-Sensing Range | I _{PR} | | -20 | _ | 20 | Α |
| Sensitivity | Sens | $I_{PR(min)} < I_P < I_{PR(max)}$ | _ | 100 | _ | mV/A |
| Zero-Current Output Voltage | V _{IOUT(Q)} | Bidirectional, I _P = 0 A | _ | V _{CC} × 0.5 | - | V |
| ACCURACY PERFORMANC | E | | | | | |
| Total Output Error [2] | E _{TOT} | $I_P = I_{PR(max)}, T_A = 25^{\circ}C \text{ to } 150^{\circ}C$ | -2 | ±0.8 | 2 | % |
| Total Output Error (=) | | $I_{P} = I_{PR(max)}, T_{A} = -40^{\circ}C \text{ to } 25^{\circ}C$ | -6 | ±4 | 6 | % |
| TOTAL OUTPUT ERROR CO | MPONENTS | S [3] E _{TOT} = E _{SENS} + 100 × V _{OE} /(Sens × I _P) | | | | |
| Sonoitivity Error | _ | $I_P = I_{PR(max)}, T_A = 25^{\circ}C \text{ to } 150^{\circ}C$ | -1.5 | ±0.6 | 1.5 | % |
| Sensitivity Error | E _{sens} | $I_P = I_{PR(max)}$, $T_A = -40$ °C to 25°C | -5.5 | ±4 | 5.5 | % |
| Offset Voltage | V | I _P = 0 A, T _A = 25°C to 150°C | -10 | ±5 | 10 | mV |
| Offset voltage | V _{OE} | $I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$ | -30 | ±6 | 30 | mV |
| LIFETIME DRIFT CHARACT | ERISTICS | | | | | |
| Sensitivity Error Lifetime Drift | E _{sens_drift} | | -3 | ±1 | 3 | % |
| Total Output Error Lifetime Drift | E _{tot_drift} | | -3 | ±1 | 3 | % |

^[1] Typical values with +/- are 3 sigma values.



^[2] Percentage of I_P, with I_P = I_{PR(max)}.

[3] A single part will not have both the maximum/minimum sensitivity error and maximum/minimum offset voltage, as that would violate the maximum/minimum total output error specification. Also, 3 sigma distribution values are combined by taking the square root of the sum of the squares. See Application Information section.

Automotive-Grade, Galvanically Isolated Current Sensor IC with Common-Mode Field Rejection in a Small-Footprint SOIC8 Package

xLLCTR-30AU PERFORMANCE CHARACTERISTICS: T_A Range L, valid at $T_A = -40$ °C to 150°C, $V_{CC} = 5$ V, unless otherwise specified

| Characteristic | Symbol | Test Conditions | Min. | Typ. [1] | Max. | Unit |
|-----------------------------------|-------------------------|-----------------------------------------------------------------------|------|-----------------------|------|------|
| NOMINAL PERFORMANCE | | | • | | | |
| Current-Sensing Range | I _{PR} | | 0 | - 1 | 30 | А |
| Sensitivity | Sens | $I_{PR(min)} < I_{P} < I_{PR(max)}$ | _ | 133 | - | mV/A |
| Zero-Current Output Voltage | V _{IOUT(Q)} | Unidirectional, I _P = 0 A | _ | V _{CC} × 0.1 | - | V |
| ACCURACY PERFORMANC | E | | | | | |
| Total Output Error [2] | E _{TOT} | $I_{P} = I_{PR(max)}, T_{A} = 25^{\circ}C \text{ to } 150^{\circ}C$ | -2 | ±0.7 | 2 | % |
| Total Output Error (=) | | $I_P = I_{PR(max)}$, $T_A = -40$ °C to 25°C | -6 | ±4 | 6 | % |
| TOTAL OUTPUT ERROR CO | MPONENTS | $S^{[3]}E_{TOT} = E_{SENS} + 100 \times V_{OE}/(Sens \times I_P)$ | | | | |
| O Markey Frances | E _{sens} | $I_{P} = I_{PR(max)}, T_{A} = 25^{\circ}C \text{ to } 150^{\circ}C$ | -1.5 | ±0.7 | 1.5 | % |
| Sensitivity Error | | $I_{P} = I_{PR(max)}, T_{A} = -40^{\circ}C \text{ to } 25^{\circ}C$ | -5.5 | ±4 | 5.5 | % |
| Offeet Veltage | V _{OE} | I _P = 0 A, T _A = 25°C to 150°C | -10 | ±6 | 10 | mV |
| Offset Voltage | | $I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$ | -30 | ±7 | 30 | mV |
| LIFETIME DRIFT CHARACT | ERISTICS | - | | | | |
| Sensitivity Error Lifetime Drift | E _{sens_drift} | | -3 | ±1 | 3 | % |
| Total Output Error Lifetime Drift | E _{tot_drift} | | -3 | ±1 | 3 | % |

^[1] Typical values with +/- are 3 sigma values.



^[3] A single part will not have both the maximum/minimum sensitivity error and maximum/minimum offset voltage, as that would violate the maximum/minimum total output error specification. Also, 3 sigma distribution values are combined by taking the square root of the sum of the squares. See Application Information section.

Automotive-Grade, Galvanically Isolated Current Sensor IC with Common-Mode Field Rejection in a Small-Footprint SOIC8 Package

xLLCTR-30AB PERFORMANCE CHARACTERISTICS: T_A Range L, valid at $T_A = -40$ °C to 150°C, $V_{CC} = 5$ V, unless otherwise specified

| Characteristic | Symbol | Test Conditions | Min. | Typ. [1] | Max. | Unit |
|-----------------------------------|-------------------------|---------------------------------------------------------------------|------|-----------------------|------|------|
| NOMINAL PERFORMANCE | | | • | | | |
| Current-Sensing Range | I _{PR} | | -30 | - 1 | 30 | Α |
| Sensitivity | Sens | $I_{PR(min)} < I_{P} < I_{PR(max)}$ | _ | 66 | - | mV/A |
| Zero-Current Output Voltage | V _{IOUT(Q)} | Bidirectional, I _P = 0 A | _ | V _{CC} × 0.5 | - | V |
| ACCURACY PERFORMANC | E | | | | | |
| T-1-1 O-1-1 F [2] | E _{TOT} | $I_{P} = I_{PR(max)}, T_{A} = 25^{\circ}C \text{ to } 150^{\circ}C$ | -2 | ±0.8 | 2 | % |
| Total Output Error [2] | | $I_P = I_{PR(max)}$, $T_A = -40$ °C to 25°C | -6 | ±4 | 6 | % |
| TOTAL OUTPUT ERROR CO | MPONENT | $S^{[3]}E_{TOT} = E_{SENS} + 100 \times V_{OE}/(Sens \times I_P)$ | | | | |
| O Markey Frances | E _{sens} | $I_{P} = I_{PR(max)}, T_{A} = 25^{\circ}C \text{ to } 150^{\circ}C$ | -1.5 | ±0.8 | 1.5 | % |
| Sensitivity Error | | $I_{P} = I_{PR(max)}, T_{A} = -40^{\circ}C \text{ to } 25^{\circ}C$ | -5.5 | ±4 | 5.5 | % |
| Offeet Veltage | Vor | I _P = 0 A, T _A = 25°C to 150°C | -10 | ±6 | 10 | mV |
| Offset Voltage | | I _P = 0 A, T _A = -40°C to 25°C | -30 | ±6 | 30 | mV |
| LIFETIME DRIFT CHARACT | ERISTICS | | | | | |
| Sensitivity Error Lifetime Drift | E _{sens_drift} | | -3 | ±1 | 3 | % |
| Total Output Error Lifetime Drift | E _{tot_drift} | | -3 | ±1 | 3 | % |

^[1] Typical values with +/- are 3 sigma values.



^[3] A single part will not have both the maximum/minimum sensitivity error and maximum/minimum offset voltage, as that would violate the maximum/minimum total output error specification. Also, 3 sigma distribution values are combined by taking the square root of the sum of the squares. See Application Information section.

Automotive-Grade, Galvanically Isolated Current Sensor IC with Common-Mode Field Rejection in a Small-Footprint SOIC8 Package

xLLCTR-40AU PERFORMANCE CHARACTERISTICS: T_A Range L, valid at $T_A = -40$ °C to 150°C, $V_{CC} = 5$ V, unless otherwise specified

| Characteristic | Symbol | Test Conditions | Min. | Typ. [1] | Max. | Unit | | |
|-----------------------------------|-------------------------|-----------------------------------------------------------------------|------|-----------------------|------|------|--|--|
| NOMINAL PERFORMANCE | | | | | | | | |
| Current-Sensing Range | I _{PR} | | 0 | - | 40 | Α | | |
| Sensitivity | Sens | $I_{PR(min)} < I_{P} < I_{PR(max)}$ | _ | 100 | _ | mV/A | | |
| Zero-Current Output Voltage | $V_{IOUT(Q)}$ | Unidirectional, I _P = 0 A | _ | V _{CC} × 0.1 | - | V | | |
| ACCURACY PERFORMANC | ACCURACY PERFORMANCE | | | | | | | |
| Total Outrot Fanon [2] | E _{TOT} | $I_P = I_{PR(max)}, T_A = 25^{\circ}C \text{ to } 150^{\circ}C$ | -2 | ±0.7 | 2 | % | | |
| Total Output Error [2] | | $I_P = I_{PR(max)}$, $T_A = -40$ °C to 25°C | -6 | ±4 | 6 | % | | |
| TOTAL OUTPUT ERROR CO | MPONENTS | $S_{[3]} E_{TOT} = E_{SENS} + 100 \times V_{OE}/(Sens \times I_P)$ | | | | | | |
| Sonoitivity Error | E _{sens} | $I_{P} = I_{PR(max)}, T_{A} = 25^{\circ}C \text{ to } 150^{\circ}C$ | -1.5 | ±0.7 | 1.5 | % | | |
| Sensitivity Error | | $I_P = I_{PR(max)}$, $T_A = -40$ °C to 25°C | -5.5 | ±4 | 5.5 | % | | |
| Offset Voltage | V _{OE} | I _P = 0 A, T _A = 25°C to 150°C | -10 | ±6 | 10 | mV | | |
| Offset Voltage | | $I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$ | -30 | ±7 | 30 | mV | | |
| LIFETIME DRIFT CHARACT | ERISTICS | _ | | | | | | |
| Sensitivity Error Lifetime Drift | E _{sens_drift} | | -3 | ±1 | 3 | % | | |
| Total Output Error Lifetime Drift | E _{tot_drift} | | -3 | ±1 | 3 | % | | |

^[1] Typical values with +/- are 3 sigma values.



^[3] A single part will not have both the maximum/minimum sensitivity error and maximum/minimum offset voltage, as that would violate the maximum/minimum total output error specification. Also, 3 sigma distribution values are combined by taking the square root of the sum of the squares. See Application Information section.

Automotive-Grade, Galvanically Isolated Current Sensor IC with Common-Mode Field Rejection in a Small-Footprint SOIC8 Package

xLLCTR-50AB PERFORMANCE CHARACTERISTICS: T_A Range L, valid at $T_A = -40$ °C to 150°C, $V_{CC} = 5$ V, $C_F = 0$, unless otherwise specified

| Characteristic | Symbol | Test Conditions | Min. | Typ. [1] | Max. | Unit | | |
|-----------------------------------|-------------------------|---------------------------------------------------------------------|------|-----------------------|------|------|--|--|
| NOMINAL PERFORMANCE | | | | | | | | |
| Current-Sensing Range | I _{PR} | | -50 | _ | 50 | А | | |
| Sensitivity | Sens | $I_{PR(min)} < I_{P} < I_{PR(max)}$ | _ | 40 | _ | mV/A | | |
| Zero-Current Output Voltage | V _{IOUT(Q)} | Bidirectional, I _P = 0 A | _ | V _{CC} × 0.5 | - | V | | |
| ACCURACY PERFORMANC | E | | | | | | | |
| Total Output Error [2] | E _{TOT} | $I_{P} = I_{PR(max)}, T_{A} = 25^{\circ}C \text{ to } 150^{\circ}C$ | -2 | ±0.8 | 2 | % | | |
| Total Output Error [2] | | $I_P = I_{PR(max)}$, $T_A = -40$ °C to 25°C | -6 | ±4 | 6 | % | | |
| TOTAL OUTPUT ERROR CO | MPONENT | $S [3] E_{TOT} = E_{SENS} + 100 \times V_{OE}/(Sens \times I_P)$ | | | | | | |
| Concitivity From | E _{sens} | $I_{P} = I_{PR(max)}, T_{A} = 25^{\circ}C \text{ to } 150^{\circ}C$ | -1.5 | ±0.8 | 1.5 | % | | |
| Sensitivity Error | | $I_P = I_{PR(max)}, T_A = -40$ °C to 25°C | -5.5 | ±4 | 5.5 | % | | |
| Offeet Voltage | \/ | I _P = 0 A, T _A = 25°C to 150°C | -10 | ±6 | 10 | mV | | |
| Offset Voltage | V _{OE} | I _P = 0 A, T _A = -40°C to 25°C | -30 | ±6 | 30 | mV | | |
| LIFETIME DRIFT CHARACT | ERISTICS | | | | | | | |
| Sensitivity Error Lifetime Drift | E _{sens_drift} | | -3 | ±1 | 3 | % | | |
| Total Output Error Lifetime Drift | E _{tot_drift} | | -3 | ±1 | 3 | % | | |

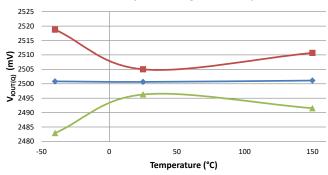
^[1] Typical values with +/- are 3 sigma values.



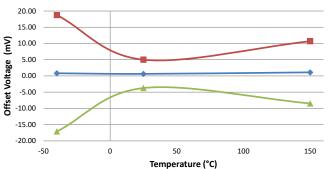
^[3] A single part will not have both the maximum/minimum sensitivity error and maximum/minimum offset voltage, as that would violate the maximum/minimum total output error specification. Also, 3 sigma distribution values are combined by taking the square root of the sum of the squares. See Application Information section.

CHARACTERISTIC PERFORMANCE xLLCTR-2P5AB

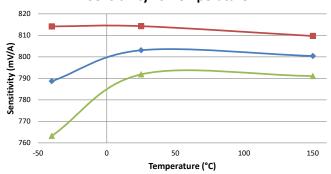




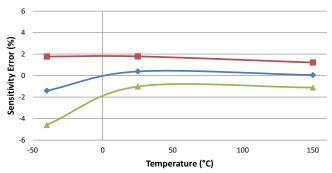
Offset Voltage vs. Temperature



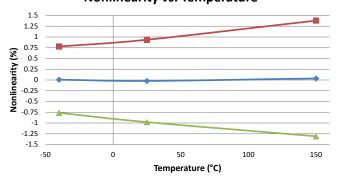
Sensitivity vs. Temperature



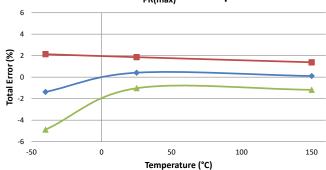
Sensitivity Error vs. Temperature



Nonlinearity vs. Temperature



Total Error at $I_{PR(max)}$ vs. Temperature





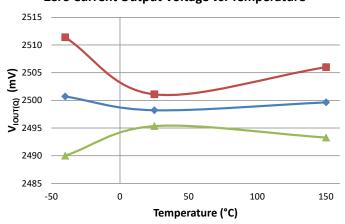


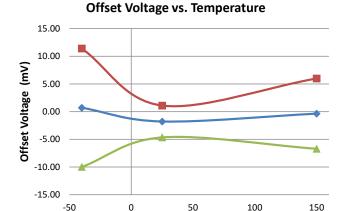




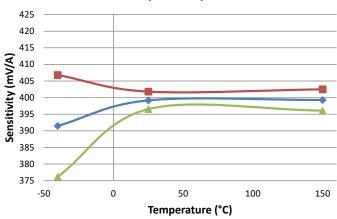
CHARACTERISTIC PERFORMANCE xLLCTR-05AB

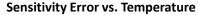




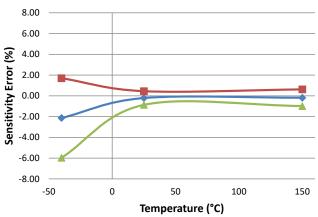


Sensitivity vs. Temperature

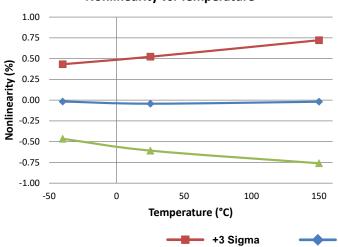




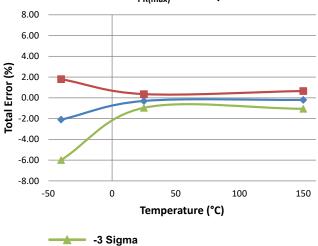
Temperature (°C)



Nonlinearity vs. Temperature

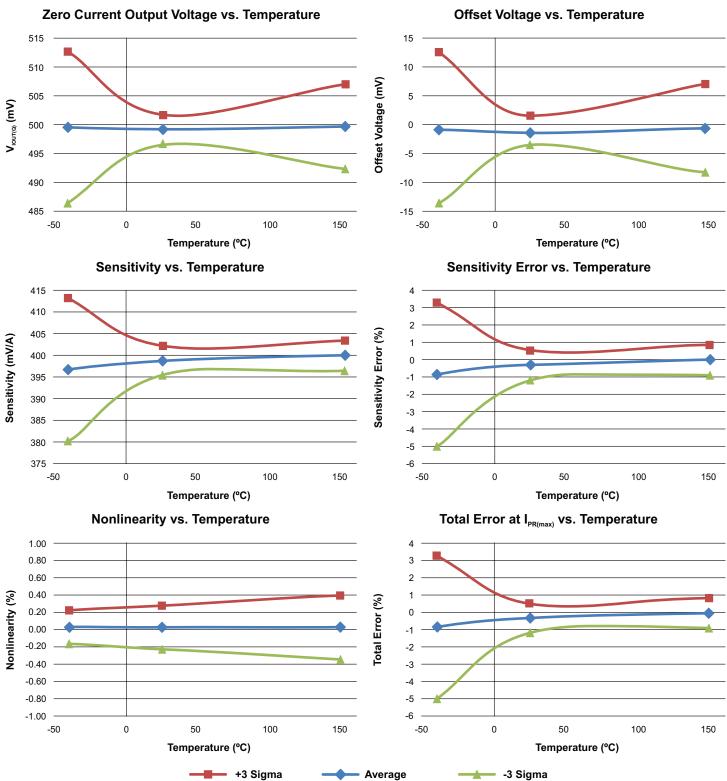


Total Error at I_{PR(max)} vs. Temperature

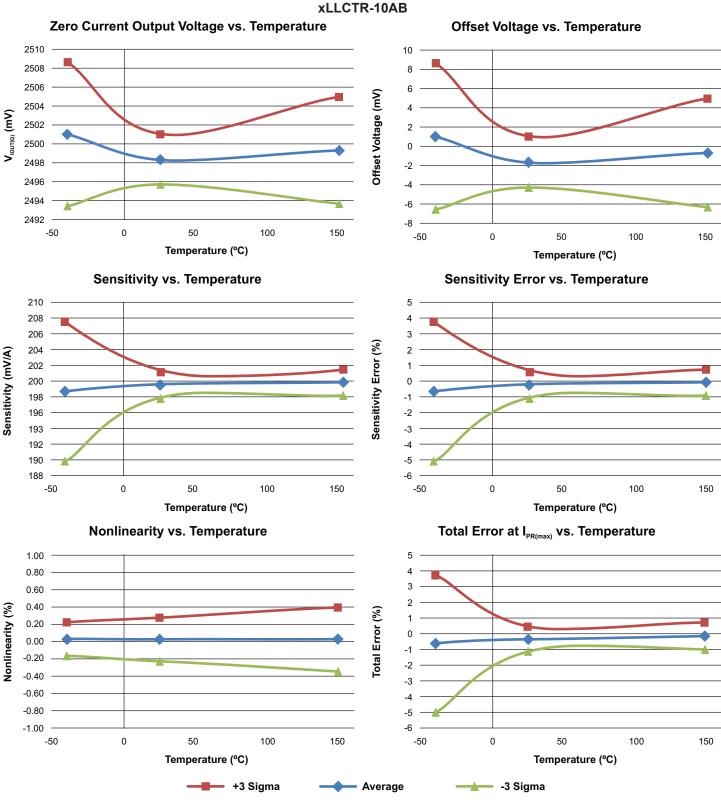


Average

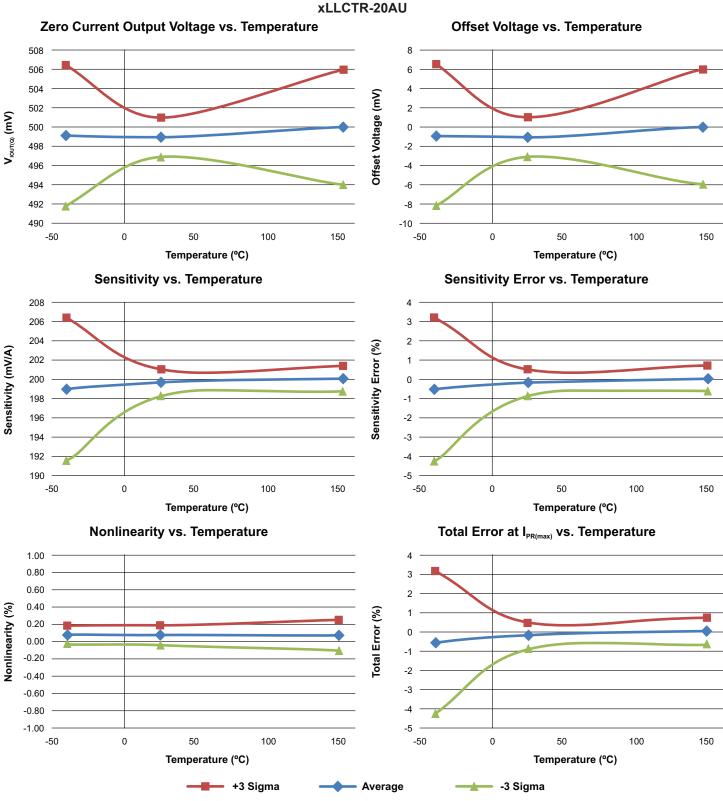
xLLCTR-10AU

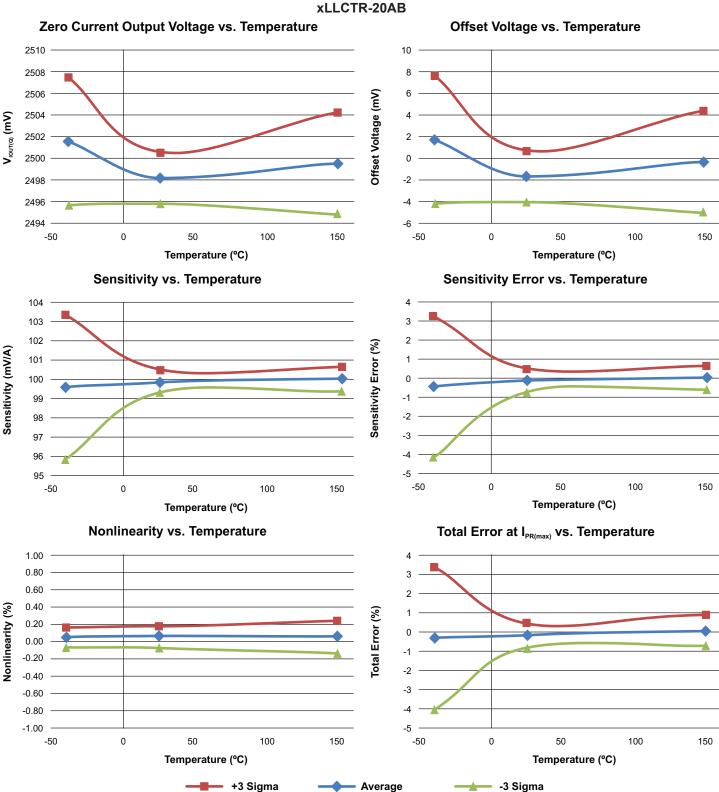




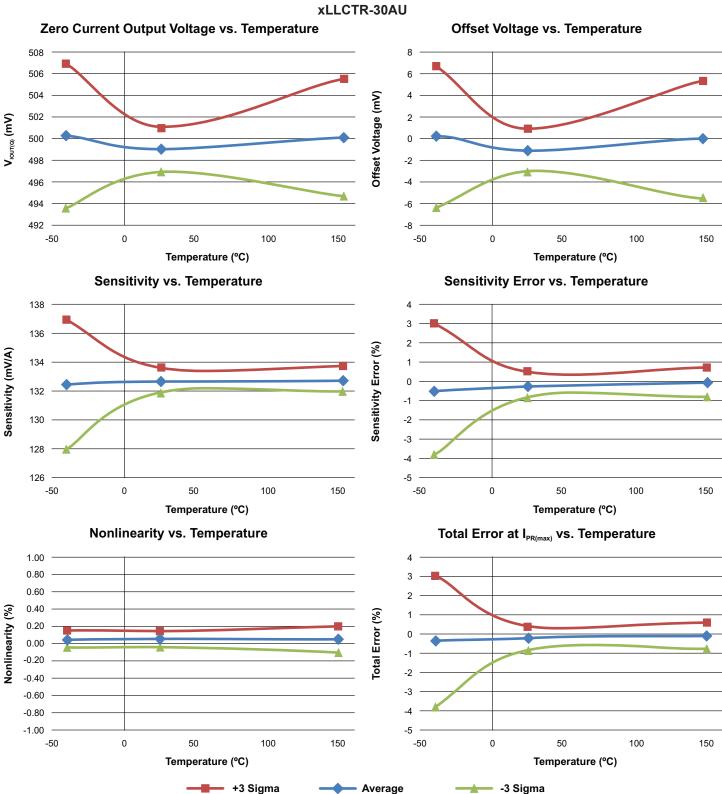




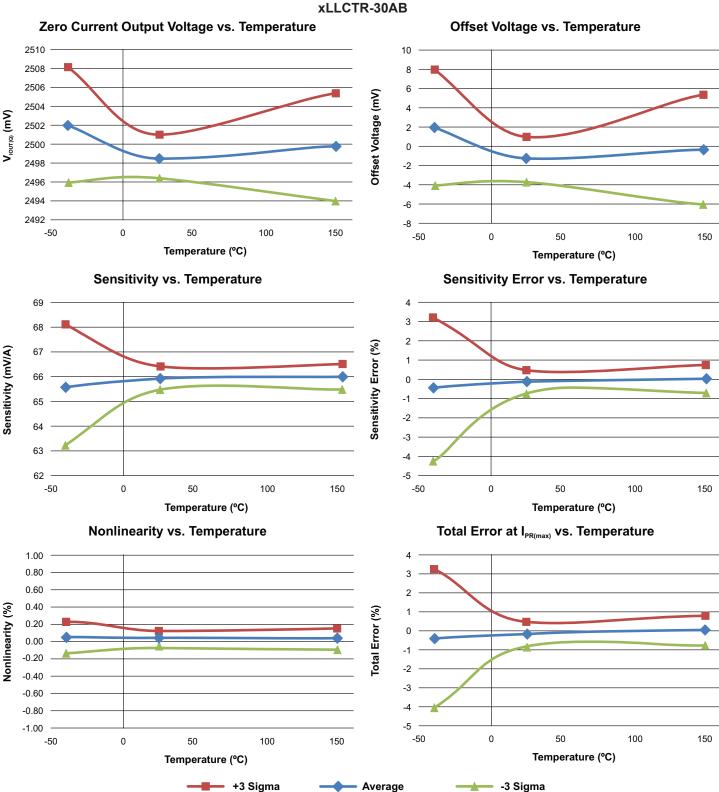






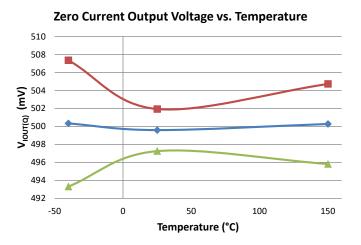


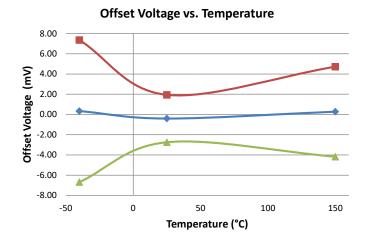


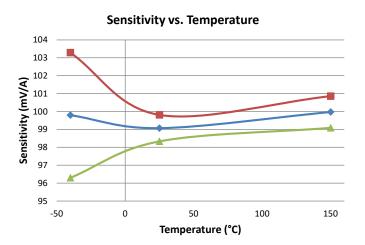


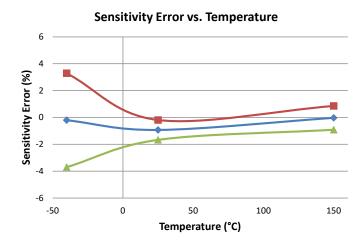


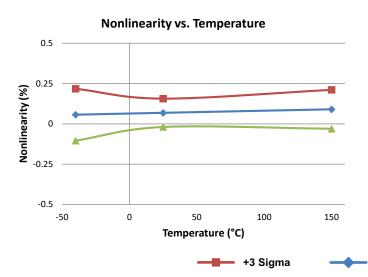
CHARACTERISTIC PERFORMANCE xLLCTR-40AU

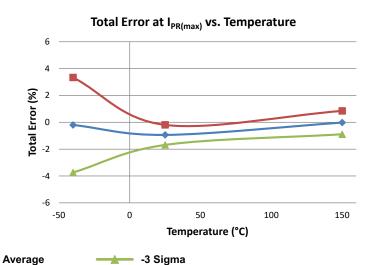




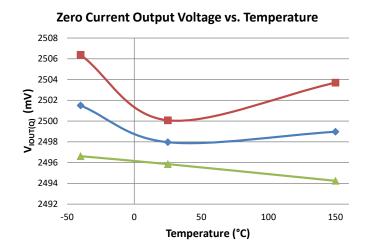


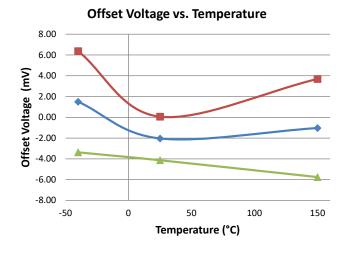


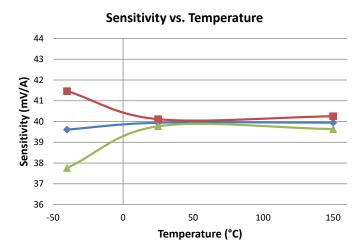


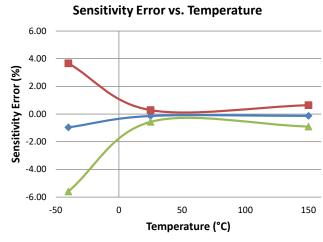


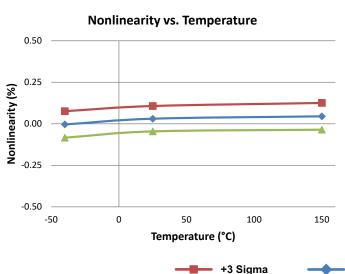
xLLCTR-50AB

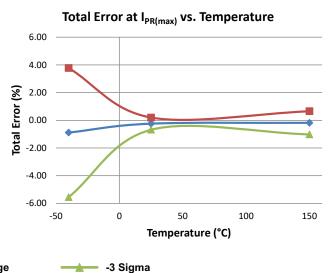






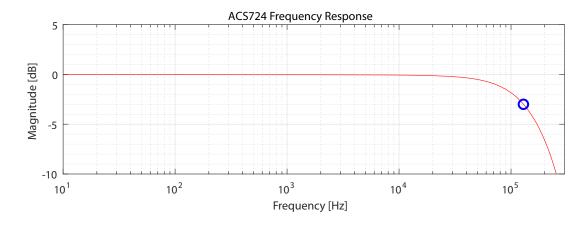


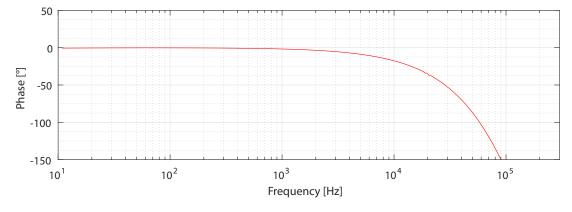




Average

CHARACTERISTIC PERFORMANCE ACS724 TYPICAL FREQUENCY RESPONSE







APPLICATION INFORMATION

Estimating Total Error vs. Sensed Current

The Performance Characteristics tables give distribution (± 3 sigma) values for Total Error at $I_{PR(max)}$; however, one often wants to know what error to expect at a particular current. This can be estimated by using the distribution data for the components of Total Error, Sensitivity Error, and Offset Voltage. The ± 3 sigma value for Total Error (E_{TOT}) as a function of the sensed current (I_P) is estimated as:

$$E_{TOT}(I_p) = \sqrt{E_{SENS}^2 + \left(\frac{100 \times V_{OE}}{Sens \times I_p}\right)^2}$$

Here, E_{SENS} and V_{OE} are the ± 3 sigma values for those error terms. If there is an average sensitivity error or average offset voltage, then the average Total Error is estimated as:

$$E_{{\scriptscriptstyle TOT_{AVG}}}(I_{\scriptscriptstyle P}) = E_{{\scriptscriptstyle SENS_{AVG}}} + \frac{100 \times V_{{\scriptscriptstyle OE_{AVG}}}}{{\scriptscriptstyle Sens} \times I_{\scriptscriptstyle P}}$$

The resulting total error will be a sum of E_{TOT} and E_{TOT_AVG} . Using these equations and the 3 sigma distributions for Sensitivity Error and Offset Voltage, the Total Error versus sensed current (I_p) is below for the ACS724LLCTR-20AB. As expected, as one goes towards zero current, the error in percent goes towards infinity due to division by zero.

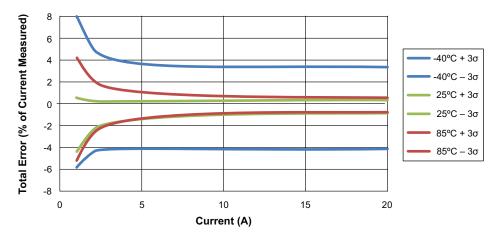


Figure 1: Predicted Total Error as a Function of the Sensed Current for the ACS724LLCTR-20AB



Thermal Rise vs. Primary Current

Self-heating due to the flow-off current should be considered during the design of any current sensing system. The sensor, printed circuit board (PCB), and contacts to the PCB will generate heat as current moves through the system.

The thermal response is highly dependent on PCB layout, copper thickness, cooling techniques, and the profile of the injected current. The current profile includes peak current, current "on-time", and duty cycle. While the data presented in this section was collected with direct current (DC), these numbers may be used to approximate thermal response for both AC signals and current pulses.

The plot in Figure 2 shows the measured rise in steady-state die temperature of the ACS724 versus DC input current at an ambient temperature, T_A , of 25 °C. The thermal offset curves may be directly applied to other values of T_A .

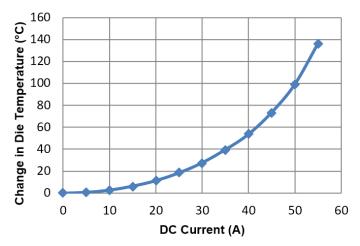


Figure 2: Self Heating in the LA Package
Due to Current Flow

The thermal capacity of the ACS724 should be verified by the end user in the application's specific conditions. The maximum junction temperature, $T_{J(MAX)}$ (165°C), should not be exceeded. Further information on this application testing is available in the DC and Transient Current Capability application note on the Allegro website.

ASEK724/5 Evaluation Board Layout

Thermal data shown in Figure 2 was collected using the ASEK724/5 Evaluation Board (TED-85-0740-003). This board includes 1500 mm² of 2 oz. copper (0.0694 mm) connected to pins 1 and 2, and to pins 3 and 4, with thermal vias connecting the layers. Top and bottom layers of the PCB are shown below in Figure 3.

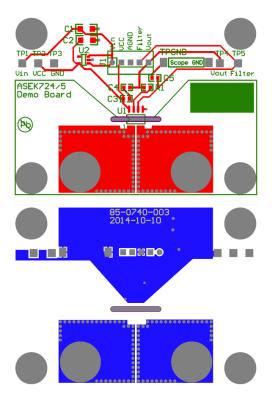


Figure 3: Top and Bottom Layers for ASEK724/5 Evaluation Board

Gerber files for the ASEK724/5 evaluation board are available for download from our website. See the technical documents section of the ACS724 device webpage.



DEFINITIONS OF ACCURACY CHARACTERISTICS

Sensitivity (Sens). The change in sensor IC output in response to a 1A change through the primary conductor. The sensitivity is the product of the magnetic circuit sensitivity (G/A) (1 G = 0.1 mT) and the linear IC amplifier gain (mV/G). The linear IC amplifier gain is programmed at the factory to optimize the sensitivity (mV/A) for the full-scale current of the device.

Nonlinearity (E_{LIN}). The nonlinearity is a measure of how linear the output of the sensor IC is over the full current measurement range. The nonlinearity is calculated as:

$$E_{LIN} = \left\{ I - \left[\frac{V_{IOUT}(I_{PR(max)}) - V_{IOUT(Q)}}{2 \bullet V_{IOUT}(I_{PR(max)}/2) - V_{IOUT(Q)}} \right] \right\} \bullet 100(\%)$$

where $V_{IOUT}(I_{PR}(max))$ is the output of the sensor IC with the maximum measurement current flowing through it and $V_{IOUT}(I_{PR}(max)/2)$ is the output of the sensor IC with half of the maximum measurement current flowing through it.

Zero-Current Output Voltage (V_{IOUT(Q)}**).** The output of the sensor when the primary current is zero. For a unipolar supply voltage, it nominally remains at $0.5 \times V_{CC}$ for a bidirectional device and $0.1 \times V_{CC}$ for a unidirectional device. For example, in the case of a bidirectional output device, $V_{CC} = 5$ V translates into $V_{IOUT(Q)} = 2.5$ V. Variation in $V_{IOUT(Q)}$ can be attributed to the resolution of the Allegro linear IC quiescent voltage trim and thermal drift.

Offset Voltage (V_{OE}). The deviation of the device output from its ideal quiescent value of $0.5 \times V_{CC}$ (bidirectional) or $0.1 \times V_{CC}$ (unidirectional) due to nonmagnetic causes. To convert this voltage to amperes, divide by the device sensitivity, Sens.

Total Output Error (E_{TOT}). The difference between the current measurement from the sensor IC and the actual current (I_p), relative to the actual current. This is equivalent to the difference between the ideal output voltage and the actual output voltage, divided by the ideal sensitivity, relative to the current flowing through the primary conduction path:

$$E_{TOT}(I_p) = \frac{V_{IOUT_ideal}(I_p) - V_{IOUT}(I_p)}{Sens_{ideal}(I_p) \bullet I_p} \bullet 100 (\%)$$

The Total Output Error incorporates all sources of error and is a function of I_P . At relatively high currents, E_{TOT} will be mostly due to sensitivity error, and at relatively low currents, E_{TOT} will be mostly due to Offset Voltage (V_{OE}). In fact, at $I_P = 0$, E_{TOT} approaches infinity due to the offset. This is illustrated in Figure 4 and Figure 5. Figure 4 shows a distribution of output voltages versus I_P at 25°C and across temperature. Figure 5 shows the corresponding E_{TOT} versus I_P .

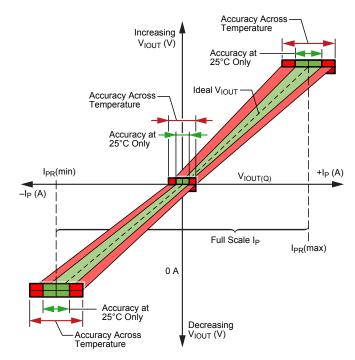


Figure 4: Output Voltage versus Sensed Current

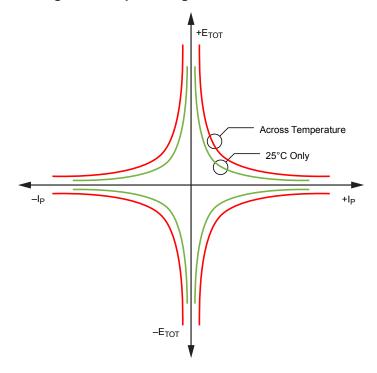


Figure 5: Total Output Error versus Sensed Current



Automotive-Grade, Galvanically Isolated Current Sensor IC with Common-Mode Field Rejection in a Small-Footprint SOIC8 Package

is described by the following equation:

Sensitivity Ratiometry Coefficient (SENS_RAT_COEF). The coefficient defining how the sensitivity scales with $V_{\rm CC}$. The ideal coefficient is 1, meaning the sensitivity scales proportionally with $V_{\rm CC}$. A 10% increase in $V_{\rm CC}$ results in a 10% increase in sensitivity. A coefficient of 1.1 means that the sensitivity increases by 10% more than the ideal proportionality case. This means that a 10% increase in $V_{\rm CC}$ results in an 11% increase in sensitivity. This relationship is described by the following equation:

$$Sens(V_{cc}) = Sens(5 \ V) \left[1 + \frac{(V_{cc} - 5 \ V) \cdot SENS_RAT_COEF}{5 \ V} \right]$$

This can be rearranged to define the sensitivity ratiometry coefficient as:

$$SENS_RAT_COEF = \left[\frac{Sens(V_{cc})}{Sens(5\ V)} - 1 \right] \bullet \frac{5\ V}{(V_{cc} - 5\ V)}$$

Zero-Current Output Ratiometry Coefficient (QVO_RAT_COEF). The coefficient defining how the zero-current output voltage scales with V_{CC} . The ideal coefficient is 1, meaning the output voltage scales proportionally with V_{CC} , always being equal to $V_{CC}/2$. A coefficient of 1.1 means that the zero-current output voltage increases by 10% more than the ideal proportionality case. This means that a 10% increase in V_{CC} results in an

$$VIOUTQ(V_{cc}) = VIOUTQ(5\ V) \left[I + \frac{(V_{cc} - 5\ V) \cdot QVO_RAT_COEF}{5\ V} \right]$$

11% increase in the zero-current output voltage. This relationship

This can be rearranged to define the zero-current output ratiometry coefficient as:

$$QVO_RAT_COEF = \left[\frac{VIOUTQ(V_{cc})}{VIOUTQ(5\ V)} - 1\right] \bullet \frac{5\ V}{(V_{cc} - 5\ V)}$$



DEFINITIONS OF DYNAMIC RESPONSE CHARACTERISTICS

Power-On Time (t_{PO}) . When the supply is ramped to its operating voltage, the device requires a finite time to power its internal components before responding to an input magnetic field. Power-On Time, t_{PO} , is defined as the time it takes for the output voltage to settle within $\pm 10\%$ of its steady-state value under an applied magnetic field, after the power supply has reached its minimum specified operating voltage, V_{CC}(min), as shown in the chart at right.

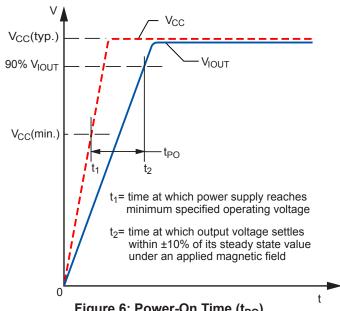


Figure 6: Power-On Time (t_{PO})

Rise Time (t_r) . The time interval between a) when the sensor IC reaches 10% of its full-scale value, and b) when it reaches 90% of its full-scale value. The rise time to a step response is used to derive the bandwidth of the current sensor IC, in which f(-3 dB)= $0.35/t_r$. Both t_r and $t_{RESPONSE}$ are detrimentally affected by eddy-current losses observed in the conductive IC ground plane.

Propagation Delay (t_{pd}) . The propagation delay is measured as the time interval a) when the primary current signal reaches 20% of its final value, and b) when the device reaches 20% of its output corresponding to the applied current.

Response Time ($t_{RESPONSE}$). The time interval between a) when the primary current signal reaches 90% of its final value, and b) when the device reaches 90% of its output corresponding to the applied current.

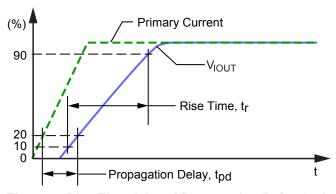
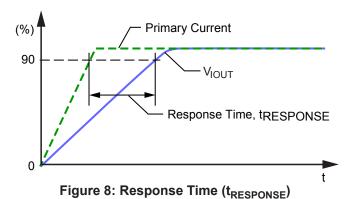


Figure 7: Rise Time (t_r) and Propagation Delay (t_{nd})





PACKAGE OUTLING DRAWING

For Reference Only — Not for Tooling Use
(Reference MS-012AA)
Dimensions in millimeters – NOT TO SCALE
Dimensions exclusive of mold flash, gate burns, and dambar protrusions
Exact case and lead configuration at supplier discretion within limits shown

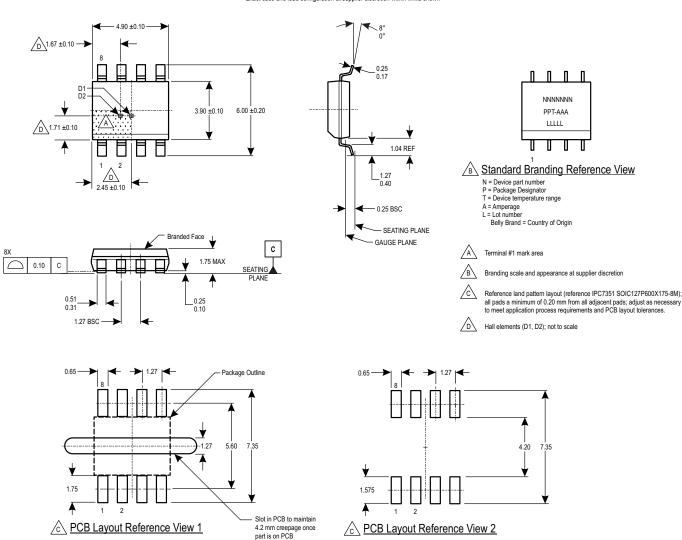


Figure 9: Package LC, 8-pin SOICN

For PCB assemblies that cannot support a slotted design,

the above stretched footprint may be used.



Automotive-Grade, Galvanically Isolated Current Sensor IC with Common-Mode Field Rejection in a Small-Footprint SOIC8 Package

Revision History

| Number | Descriptioon | Pages | Responsible | Date | |
|--------|-----------------------------------------------------------------------------------------------------------------------------------------------------|-----------|-------------------------|-------------------|--|
| - | Added Characteristic Performance graphs and Application Information to Preliminary draft to create Final draft | All | A. Latham | January 16, 2015 | |
| 1 | Corrected Features and Benefits | 2 | A. Latham | June 19, 2015 | |
| 2 | Added ACS724LLCTR-50AB-T variant with electrical characteristics | 2, 9 | A. Latham | June 23, 2015 | |
| 3 | Corrected Characteristic Performance graph legends; updated Lifetime Drift Characteristics and added Error Over Lifetime electrical characteristics | 6-18 | A. Latham, S. Milano | August 12, 2015 | |
| 4 | Added ACS724LLCTR-05AB-T variant with electrical characteristics | 2, 6 | W. Bussing | August 8, 2016 | |
| 5 | Added AEC-Q100 qualified status | 1 | W. Bussing | June 28, 2017 | |
| 6 | Added ACS724LLCTR-05AB-T and ACS724LLCTR-50AB-T Characteristic Performance graphs | 14, 21 | W. Bussing | August 3, 2017 | |
| 7 | Updated Clearance and Creepage rating values | 3 | W. Bussing | January 10, 2018 | |
| 8 | Added Dielectric Surge Strength Test Voltage characteristic | 2 | W Dunning | January 02, 2040 | |
| 0 | Added Common Mode Field Rejection Ratio characteristic | 5 | W. Bussing | January 23, 2018 | |
| 9 | Added ACS724LLCTR-2P5AB-T variant with electrical characteristics | 2, 6 | W Bussins | April 13, 2018 | |
| 9 | Updated PCB Layout References in Package Outline Drawing | 27 | W. Bussing | April 13, 2016 | |
| | Added Hall dimensions in Package Outline Drawing | 27 | | | |
| 10 | Added ACS724LLCTR-40AU-T variant with electrical characteristics and performance graphs | 2, 14, 23 | W. Bussing | May 14, 2018 | |
| 11 | Added ACS724LLCTR-2P5AB-T performance graphs | 16 | M. McNally | lum = 00, 0040 | |
| 11 | Added Typical Frequency Response plots | 26 | W. Bussing | June 22, 2018 | |
| 12 | Added "Thermal Rise vs. Primary Current" and "ASEK724/5 Evaluation Board Layout" to the Applications Information section | 28 | W. Bussing | July 3, 2018 | |
| 13 | Corrected ACS724LLCTR-40AU-T Total Output Error and Sensitivity Error values | 14 | M. McNally | November 15, 2018 | |
| 14 | Updated certificate numbers | 1 | V. Mach | December 13, 2018 | |
| 15 | Updated TUV certificate mark | 1 | M. McNally | June 3, 2019 | |

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